# Am79M574

#### Metering Subscriber Line Interface Circuit

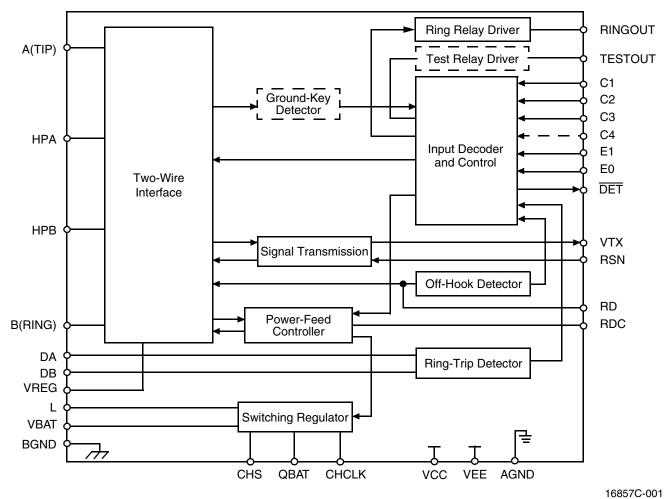
#### **DISTINCTIVE CHARACTERISTICS**

- Programmable constant-resistance feed
- Programmable loop-detect threshold
- Ground-key detect
- Performs polarity reversal
- Line-feed characteristics independent of battery variations
- Test relay driver optional
- **BLOCK DIAGRAM**

Supports 2.2 Vrms metering (12 and 16 kHz)

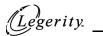
Legerity.

- On-chip switching regulator for low-power dissipation
- Two-wire impedance set by single external impedance
- Tip Open state for ground-start lines
- On-hook transmission



Notes:

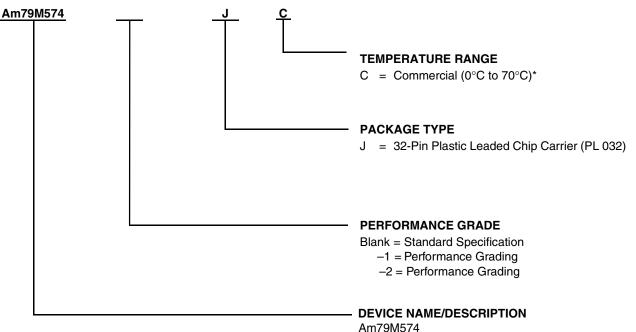
- 1. Am79M574—E0 and E1 inputs; ring and test relay drivers sourced internally to BGND.
- 2. Current gain  $(K_1) = 1000$ .



#### **ORDERING INFORMATION**

#### **Standard Products**

Legerity standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



Subscriber Line Interface Circuit

Valid Combinations				
Am79M574	–1	JC		
	-2			

#### Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Legerity sales office to confirm availability of specific valid combinations, to check on newly released combinations, and to obtain additional data on Legerity's standard military grade products.

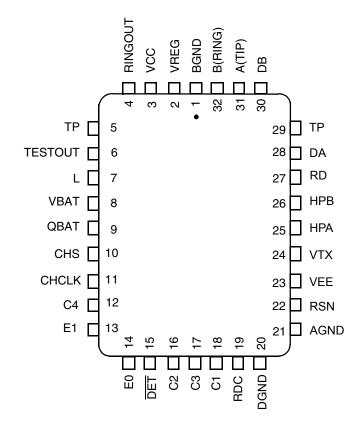
#### Note:

2

\* Functionality of the device from  $0^{\circ}C$  to  $+70^{\circ}C$  is guaranteed by production testing. Performance from  $-40^{\circ}C$  to  $+85^{\circ}C$  is guaranteed by characterization and periodic sampling of production units.

### CONNECTION DIAGRAM

**Top View** 



#### Notes:

- 1. Pin 1 is marked for orientation.
- 2. TP is a thermal conduction pin tied to substrate (QBAT).
- 3. NC = No connect

, Legerity.

# (Legerity\_\_\_\_\_

#### **PIN DESCRIPTIONS**

Pin Names	Туре	Description
AGND	Gnd	Analog (quiet) ground
A(TIP)	Output	Output of A(TIP) power amplifier
BGND	Gnd	Battery (power) ground
B(RING)	Output	Output of B(RING) power amplifier
C3–C1	Input	Decoder. TTL compatible. C3 is MSB and C1 is LSB.
C4	Input	Test relay driver command. TTL compatible. A logic Low enables the driver.
CHCLK	Input	Chopper clock. Input to switching regulator (TTL compatible). Frequency = 256 kHz (Nominal).
CHS	Input	Chopper Stabilization. Connection for external stabilization components.
DA	Input	Ring-trip negative. Negative input to ring-trip comparator.
DB	Input	Ring-trip positive. Positive input to ring-trip comparator.
DET	Output	Detector. When enabled, a logic Low indicates that the selected detector is tripped. Logic inputs C3–C1, E1, and E0 select the detector. Open-collector with a built-in 15 k $\Omega$ pull-up resistor.
DGND	Gnd	Digital ground
E0	Input	Read Enable. A logic High enables DET. A logic Low disables DET.
E1	Input	Ground enable. When E0 is High, E1 = High connects the ground-key detector to $\overline{DET}$ , and E1 = Low connects the off-hook or ring-trip detector to $\overline{DET}$ .
HPA	Capacitor	High-pass filter capacitor. A(TIP) side of high-pass filter capacitor.
HPB	Capacitor	High-pass filter capacitor. B(RING) side of high-pass filter capacitor.
L	Output	Switching Regulator Power Transistor. Connection point for filter inductor and anode of catch diode. Has up to 60 V of pulse waveform and must be isolated from sensitive circuits. Keep the diode connections short because of the high currents and high di/dt.
QBAT	Battery	Quiet Battery. Filtered battery supply for the signal processing circuits.
RD	Resistor	Detector resistor. Threshold modification and filter point for the off-hook detector.
RDC	Resistor	DC feed resistor. Connection point for the DC feed resistance programming network, which also connects to the Receiver Summing Node (RSN). V <sub>RDC</sub> is negative for normal polarity and positive for reverse polarity.
RINGOUT	Output	Ring relay driver. Sourcing from BGND with internal diode to QBAT.
RSN	Input	Receive Summing Node. The metallic current (AC and DC) between A(TIP) and B(RING) = 1000 x the current into this pin. The networks that program receive gain, two-wire impedance, and feed resistance all connect to this node. This node is extremely sensitive. Route the 256 kHz chopper clock and switch lines away from the RSN node.
TESTOUT	Output	Test relay driver. Sourcing from BGND with internal diode to QBAT.
TP	Thermal	Thermal pin. Connection for heat dissipation. Internally connected to substrate (QBAT). Leave as open circuit or connected to QBAT. In both cases, the TP pins can connect to an area of copper on the board to enhance heat dissipation.
VBAT	Battery	Battery supply. Connected to office battery supply through an external protection diode.
VCC	Power	+5 V power supply
VEE	Power	-5 V power supply
VREG	Input	Regulated Voltage. Provides negative power supply for power amplifiers, connection point for inductor, filter capacitor, and chopper stabilization.
VTX	Output	Transmit Audio. This output is 0.510 times the A(TIP) and B(RING) metallic voltage. The other end of the two-wire input impedance programming network connects here.



#### **ABSOLUTE MAXIMUM RATINGS**

Storage temperature55°C to +150°C
$V_{CC}$ with respect to AGND/DGND $\ldots$ –0.4 V to +7.0 V
$V_{\text{EE}}$ with respect to AGND/DGND $\ldots$ +0.4 V to –7.0 V
$V_{BAT}$ with respect to AGND/DGND +0.4 V to –70 V
<b>Note:</b> Rise time of $V_{BAT}$ (dv/dt) must be limited to 27 V/µs or less when $Q_{BAT}$ bypass = 0.33 µF.
BGND with respect to AGND/DGND+1.0 V to -3.0 V
A(TIP) or B(RING) to BGND:
Continuous
10 ms (f = 0.1 Hz)70 V to +5.0 V 1 μs (f = 0.1 Hz)90 V to +10 V
250 ns (f = 0.1 Hz)–120 V to +15 V
Current from A(TIP) or B(RING)±150 mA
Voltage on RINGOUT BGND to 70 V above $Q_{BAT}$
Voltage on TESTOUT BGND to 70 V above $\textbf{Q}_{\text{BAT}}$
Current through relay drivers 60 mA
Voltage on ring-trip inputs
(DA and DB) V <sub>BAT</sub> to 0 V
Current into ring-trip inputs±10 mA
Peak current into regulator switch (L pin) 150 mA
Switcher transient peak off voltage on L pin +1.0 V
C4–C1, E0, E1, CHCLK to AGND/DGND0.4 V to V <sub>CC</sub> + 0.4 V
Maximum power dissipation, (see note) $T_A = 70^{\circ}C$ In 32-pin PLCC package 1.74 W

**Note:** Thermal limiting circuitry on chip will shut down the circuit at a junction temperature of about 165°C. The device should never be exposed to this temperature. Operation above 145°C junction temperature may degrade device reliability. See the SLIC Packaging Considerations for more information.

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

#### **OPERATING RANGES**

#### Commercial (C) Devices

Ambient temperature0°C to +70°C	
$V_{CC}$	
V <sub>EE</sub> –4.75 V to –5.25 V	
$V_{\text{BAT}},\ldots\ldots$ –40 V to –58 V	
AGND/DGND 0 V	
BGND with respect to AGND/DGND	
Load resistance on VTX to ground 10 k $\Omega$ min	

Operating Ranges define those limits between which the functionality of the device is guaranteed.

\* Functionality of the device from  $0^{\circ}C$  to  $+70^{\circ}C$  is guaranteed by production testing. Performance from  $-40^{\circ}C$  to  $+85^{\circ}C$  is guaranteed by characterization and periodic sampling of production units.



#### **ELECTRICAL CHARACTERISTICS**

Desc	cription	Test Conditions (See Note 1	)	Min	Тур	Max	Unit	Note
Analog (V <sub>TX</sub> ) οι	utput impedance				3		Ω	
Analog (V <sub>TX</sub> ) output offset		0°C to +70°C -40°C to +85°C	-1* -1	-35 -30 -40 -35		+35 +30 +40 +35	mV	4 4
	nput impedance pedance at A or B	300 Hz to 3.4 kHz			1	20 35	Ω	4
Overload level $Z_{2WIN} = 600 \ \Omega$	to 900 Ω	4-wire 2-wire		-3.1 -6.0		+3.1 +6.0	Vpk	2
Transmission	Performance, 2-W	/ire Impedance						
2-wire return los (See Test Circu		300 Hz to 500 Hz 500 Hz to 2500 Hz 2500 Hz to 3400 Hz		26 26 20			dB	4, 14
Longitudinal B	alance (2-Wire ar	nd 4-Wire, See Test Circuit C)						
R <sub>L</sub> = 600 Ω, Ion metallic L-T, L-4 unity gain)		300 Hz to 3400 Hz	-1*	48 52				
Longitudinal to	metallic L-T, L-4	200 Hz to 1 kHz normal polarity 0°C to +70°C normal polarity -40°C to +85°C reverse polarity	-2* -2 -2	63 58 54			dB	4
		1 kHz to 3.4 kHz normal polarity 0°C to +70°C normal polarity –40°C to +85°C reverse polarity	-2* -2 -2	58 54 54				4
Longitudinal sig generation 4-L	Inal	300 Hz to 800 Hz 300 Hz to 800 Hz	-1*	40 42				
Longitudinal cu per wire	rrent capability	Active state OHT state			25 18		mArms	4
Insertion Loss	(2- to 4-Wire and	4- to 2-Wire, See Test Circuits A a	nd B)				•	
Gain accuracy	2- to 4-wire 2- to 4-wire 2- to 4-wire 2- to 4-wire	0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz, -40°C to +85°C 0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz, -40°C to +85°C	-1* -1	5.75 5.65 5.75 5.70	5.85 5.85 5.85 5.85	6.00 6.05 5.95 6.00		4 
	4- to 2-wire 4- to 2-wire 4- to 2-wire 4- to 2-wire	0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz, -40°C to +85°C 0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz, -40°C to +85°C	-1* -1	-0.15 -0.20 -0.1 -0.15		+0.15 +0.20 +0.1 +0.15	dB	4 4
Variation with frequency		300 Hz to 3400 Hz Relative to 1 kHz 0°C to +70°C –40°C to +85°C		0.1 0.15		+0.1 +0.15		  4
Gain tracking		+7 dBm to –55 dBm, ref 0 dBm 0°C to +70°C –40°C to +85°C		0.1 0.15		+0.1 +0.15		 4 4

Notes:

\* P.G. = Performance Grade

-2 grade performance parameters are equivalent to -1 performance parameters except where indicated.

(Legerity

#### **ELECTRICAL CHARACTERISTICS (continued)**

Description	Test Conditions (See Note 1)	Min	Тур	Max	Unit	Note
Balance Return Signal (4- to 4-V	Vire, See Test Circuit B)			•	•	
Gain accuracy	0 dBm, 1 kHz, 0°C to +70°C 0 dBm, 1 kHz, -40°C to +85°C 0 dBm, 1 kHz, 0°C to +70°C -1* 0 dBm, 1 kHz, -40°C to +85°C -1	-6.00 -6.05 -5.95 -6.00	-5.85 -5.85 -5.85 -5.85	-5.75 -5.65 -5.75 -5.70		3 3, 4 3 3, 4
Variation with frequency	300 Hz to 3400 Hz Relative to 1 kHz 0°C to +70°C -40°C to +85°C	-0.1 -0.15		+0.1 +0.15	dB	— 3, 4 3, 4
Gain tracking	+7 dBm to −55 dBm, ref 0 dBm 0°C to +70°C −40°C to +85°C	-0.1 -0.15		+0.1 +0.15		4 4
Group delay	f = 1 kHz		5.3		μs	4, 15
Total Harmonic Distortion (2- to	4-Wire or 4- to 2-Wire, See Test Circuit	s A and B)			•	
Total harmonic distortion	0 dBm, 300 Hz to 3.4 kHz +9 dBm, 300 Hz to 3.4 kHz		64 55	-50 -40	dB	
Total harmonic distortion with metering				-35		4, 11
Idle Channel Noise					•	
C-message weighted noise	2-wire, 0°C to +70°C 2-wire, 0°C to +70°C −1* 2-wire, −40°C to +85°C		+7 +7 +7	+15 +12 +15	dBrnC	4
	4-wire, 0°C to +70°C 4-wire, 0°C to +70°C -1* 4-wire, -40°C to +85°C		+7 +7 +7	+15 +12 +15		
Psophometric weighted noise	2-wire, 0°C to +70°C 2-wire, 0°C to +70°C −1* 2-wire, −40°C to +85°C		83 83 83	-75 -78 -75	dBmp	7 7 4, 7
	4-wire, 0°C to +70°C 4-wire, 0°C to +70°C −1* 4-wire, −40°C to +85°C		83 83 83	-75 -78 -75	ubinp	7 7 4, 7
Single Frequency Out-of-Band	Noise (See Test Circuit E)	ł		1		
Metallic	4 kHz to 9 kHz 9 kHz to 1 MHz 256 kHz and harmonics		76 76 57		dBm	4, 5, 9 4, 5, 9 4, 5
Longitudinal	1 kHz to 15 kHz Above 15 kHz 256 kHz and harmonics		70 85 57		UDIII	4, 5, 9 4, 5, 9 4, 5
Line Characteristics (See Figure	e 1) BAT = –48 V, R <sub>L</sub> = 600 $\Omega$ and 900 $\Omega$ ,	R <sub>FEED</sub> = 800	Ω		•	
Apparent battery voltage	Active state	47	50	53	V	
Loop-current accuracy	Active state	-7.5		+7.5		
Loop current—Tip Open state	R <sub>L</sub> = 600 Ω			1.0	1	
Loop current—Open Circuit state	$R_L = 0 \Omega$			1.0	%	
Loop-current limit accuracy	OHT state Active state	-20		+20		10
Fault current limit, I <sub>L</sub> LIM (I <sub>AX</sub> + I <sub>BX</sub> )	A and B shorted to GND			130	mA	



# (Legerity. ELECTRICAL CHARACTERISTICS (continued)

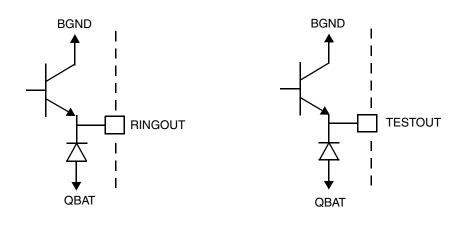
Description	Test Conditions (See Note	1)	Min	Тур	Мах	Unit	Note
Power Dissipation BAT = -48	V, Normal Polarity			L			4
On-hook Open Circuit state		-1*		35 35	120 80		
On-hook OHT state		-1*		135 135	250 200		
On-hook Active state		-1*		200 200	400 300	mW	
Off-hook OHT state	$R_L = 600 \Omega$			500	750		
Off-hook Active state	$R_L = 600 \Omega$			650	1000		
Supply Currents				L			
V <sub>CC</sub> On-hook supply current	Open Circuit state OHT state Active state			3.0 6.0 7.5	4.5 10.0 12.0		
V <sub>EE</sub> On-hook supply current	Open Circuit state OHT state Active state			1.0 2.2 2.7	2.3 3.5 6.0	mA	
V <sub>BAT</sub> On-hook supply current	Open Circuit state OHT state Active state			0.4 3.0 4.0	1.0 5.0 6.0		
Power Supply Rejection Ratio	o (V <sub>RIPPLE</sub> = 50 mVrms)						
v <sub>cc</sub>	50 Hz to 3400 Hz	-1*	25 30	45 45			6, 7
	3.4 kHz to 50 kHz	-1*	22 25	35 35			0, 1
V <sub>EE</sub>	50 Hz to 3400 Hz	-1*	20 25	40 40		dB	6, 7
	3.4 kHz to 50 kHz	-1*	10 10	25 25		uD.	0, 7
V <sub>BAT</sub>	50 Hz to 3400 Hz	-1*	27 30	45 45			6, 7
	3.4 kHz to 50 kHz	-1*	20 25	40 40			0, 1
Off-Hook Detector							
Current threshold accuracy	I <sub>DET</sub> = 365/R <sub>D</sub> Nominal		-20		+20	%	
Ground-Key Detector Thresho	olds, Active State, BAT = -48 V (Se	e Test Cir	rcuit F)				
Ground-key resistance threshole	d B(RING) to GND		2.0	5.0	10.0	kΩ	
Ground-key current threshold	B(RING) to GND Midpoint to GND			9 9		mA	8
Ring-Trip Detector Input							
Bias current			-5	-0.05		μA	
Offset voltage	Source resistance 0 to 2 $M\Omega$		-50	0	+50	mV	13

(Legerity.

#### ELECTRICAL CHARACTERISTICS (continued)

Description	Test Conditions (See Note 1)	Min	Тур	Max	Unit	Note
Logic Inputs (C4–C1, E0,	E1, and CHCLK)	4	11		1	<u>.</u>
Input High voltage		2.0			v	
Input Low voltage				0.8		
Input High current	All inputs except E1	-75		40		
Input High current	Input E1	-75		45	μA	
Input Low current		-0.4			mA	
Logic Output (DET)		1			1	1
Output Low voltage	I <sub>OUT</sub> = 0.8 mA			0.4	v	
Output High voltage	I <sub>OUT</sub> = -0.1 mA	2.4				
Relay Driver Outputs (RIN	IGOUT, TESTOUT)	1				I
On voltage	50 mA source	BGND –2	BGND0.95		V	
Off leakage			0.5	100	μA	
Clamp voltage	50 mA sink	Q <sub>BAT</sub> –2			V	

#### **RELAY DRIVER SCHEMATICS**



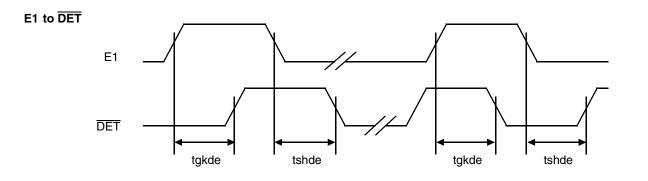
16857C-002

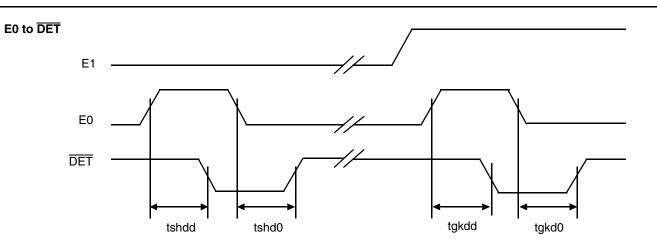


#### SWITCHING CHARACTERISTICS

Symbol	Parameter	Test Conditions	Temperature Range	Min	Тур	Max	Unit	Note
tgkde	E1 Low to $\overline{\text{DET}}$ High (E0 = 1)		0°C to +70°C –40°C to +85°C			3.8 4.0		
igitue	E1 Low to $\overline{\text{DET}}$ Low (E0 = 1)	Ground-Key Detect state $R_L$ open, $R_G$ connected	0°C to +70°C −40°C to +85°C			1.1 1.6		
tgkdd	E0 High to $\overline{\text{DET}}$ Low (E1 = 0)	(See Figure H)	0°C to +70°C –40°C to +85°C			1.1 1.6		
tgkd0	E0 Low to $\overline{\text{DET}}$ High (E1 = 0)		0°C to +70°C –40°C to +85°C			3.8 4.0		4
	E1 High to $\overline{\text{DET}}$ Low (E0 = 1)		0°C to +70°C –40°C to +85°C			1.2 1.7	μs	4
tshde	E1 High to $\overline{\text{DET}}$ High (E0 = 1)	Switchhook Detect state $R_{I} = 600 \Omega$ , $R_{G}$ open	0°C to +70°C −40°C to +85°C			3.8 4.0		
tshdd	E0 High to $\overline{\text{DET}}$ Low (E1 = 1)	(See Figure G)	0°C to +70°C –40°C to +85°C			1.1 1.6		
tshd0	E0 Low to $\overline{\text{DET}}$ High (E1 = 1)		0°C to +70°C –40°C to +85°C			3.8 4.0		

#### SWITCHING WAVEFORMS





#### Note:

10

All delays measured at 1.4 V level.

16857C-003

## Legerity.

#### Notes:

- Unless otherwise noted, test conditions are BAT = -48 V, V<sub>CC</sub> = +5 V, V<sub>EE</sub> = -5 V, R<sub>L</sub> = 600 Ω, C<sub>HP</sub> = 0.22 μF, R<sub>DC1</sub> = R<sub>DC2</sub> = 20 kΩ, C<sub>DC</sub> = 0.1 μF, R<sub>d</sub> = 51.1 kΩ, no fuse resistors, two-wire AC output impedance, programming impedance (Z<sub>T</sub>) = 306 kΩ resistive, receive input summing impedance (Z<sub>RX</sub>) = 300 kΩ resistive. (See Table 2 for component formulas.)
- 2. Overload level is defined when THD = 1%.
- Balance return signal is the signal generated at V<sub>TX</sub> by V<sub>RX</sub>. This specification assumes that the two-wire AC load impedance matches the impedance programmed by Z<sub>T</sub>.
- 4. Not tested in production. This parameter is guaranteed by characterization or correlation to other tests.
- 5. These tests are performed with a longitudinal impedance of 90  $\Omega$  and metallic impedance of 300  $\Omega$  for frequencies below 12 kHz and 135  $\Omega$  for frequencies greater than 12 kHz. These tests are extremely sensitive to circuit board layout.
- 6. This parameter is tested at 1 kHz in production. Performance at other frequencies is guaranteed by characterization.
- 7. When the SLIC is in the Anti-sat 2 operating region, this parameter is degraded. The exact degradation depends on system design. The Anti-sat 2 region occurs at high loop resistances when  $|V_{BAT}| |V_{AX} V_{BX}|$  is less than approximately 17V.
- 8. "Midpoint" is defined as the connection point between two 300  $\Omega$  series resistors connected between A(TIP) and B(RING).
- 9. Fundamental and harmonics from 256 kHz switch-regulator chopper are not included.
- 10. Loop-current limit which depends upon the programmed apparent open circuit voltage and the feed resistance is calculated as follows:

In OHT state: 
$$I_{\text{LIMIT}} = 0.5$$
  $\frac{V_{\text{apparent}}}{R_{\text{FEED}}}$  In Active state:  $I_{\text{LIMIT}} = 0.8$   $\frac{V_{\text{apparent}}}{R_{\text{FEED}}}$ 

- 11. Total harmonic distortion with metering as specified with a metering signal of 2.2 Vrms at the two-wire output, and a transmit signal of +3 dBm or receive signal of -4 dBm. The transmit or receive signals are single-frequency inputs, and the distortion is measured as the highest in-band harmonic at the two-wire or the four-wire output relative to the input signal.
- 12. Noise with metering is measured by applying a 2.2 Vrms metering signal (measured at the two-wire output) and measuring the psophometric noise at the two-wire and four-wire outputs over a 200 ms time interval.
- 13. Tested with 0  $\Omega$  source impedance. 2 M $\Omega$  is specified for system design purposes only.
- 14. Assumes the following  $Z_T$  network:

15. Group delay can be considerably reduced by using a Z<sub>T</sub> network such as that shown in Note 14. The network reduces the group delay to less than 2 μs. The effect of group delay on linecard performance may be compensated for by using the QSLAC<sup>™</sup> or DSLAC<sup>™</sup> devices.

			DET C	Dutput
State	C3 C2 C1	Two-Wire Status	E0 = 1* E1 = 0	E0 = 1* E1 = 1
0	0 0 0	Open Circuit	Ring trip	Ring trip
1	0 0 1	Ringing	Ring trip	Ring trip
2	0 1 0	Active	Loop detector	Ground key
3	0 1 1	On-hook TX (OHT)	Loop detector	Ground key
4	1 0 0	Tip Open	Loop detector	—
5	1 0 1	Reserved	Loop detector	—
6	1 1 0	Active Polarity Reversal	Loop detector	Ground key
7	1 1 1	OHT Polarity Reversal	Loop detector	Ground key

#### Table 1. SLIC Decoding

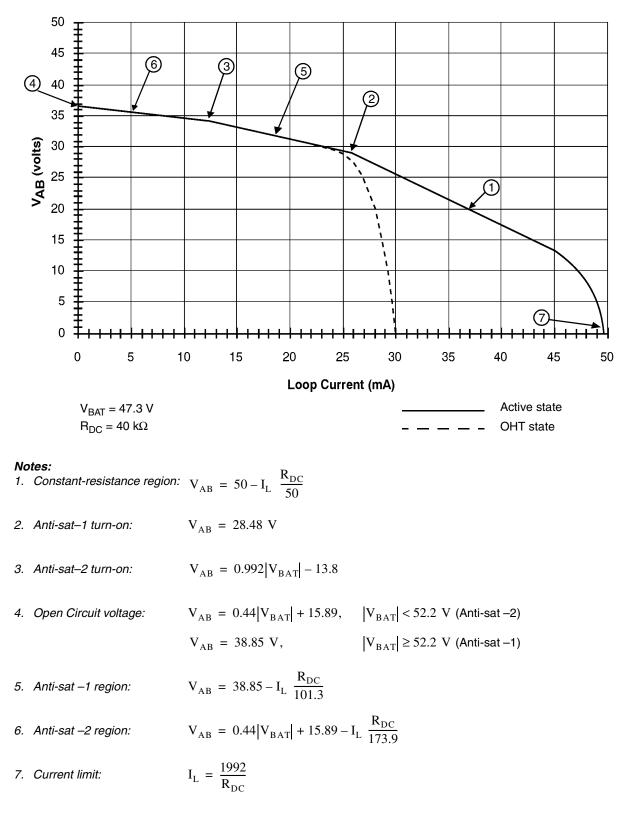
#### Note:

\* Logic Low on E0 disables the  $\overline{DET}$  output into the open-collector state.

$Z_{\rm T} = 510(Z_{\rm 2WIN} - 2R_{\rm F})$	$Z_{\rm T}$ is connected between the VTX and RSN pins. The fuse resistors are R <sub>F</sub> and $Z_{\rm 2WIN}$ is the desired 2-wire AC input impedance. When computing $Z_{\rm T}$ , the internal current amplifier pole and any external stray capacitance between VTX and RSN must be taken into account.
$Z_{RX} = \frac{Z_{L}}{G_{42L}} \bullet \frac{1000 \bullet Z_{T}}{Z_{T} + 510(Z_{L} + 2R_{F})}$	$Z_{RX}$ is connected from $V_{RX}$ to the RSN pin, $Z_T$ is defined above, and $G_{42L}$ is the desired receive gain.
$R_{DCI} + R_{DC2} = 50(R_{FEED} - 2R_F)$ $C_{DC} = 1.5 \text{ ms} \bullet \frac{R_{DC1} + R_{DC2}}{R_{DC1} \bullet R_{DC2}}$	$R_{DC1},R_{DC2}$ , and $C_{DC}$ form the network connected to the RDC pin. $R_{DC1}$ and $R_{DC2}$ are approximately equal.
$R_{\rm D} = \frac{365}{I_{\rm T}},  C_{\rm D} = \frac{0.5 \text{ ms}}{R_{\rm D}}$	$R_D$ and $C_D$ form the network connected from RD to $-5$ V and $I_T$ is the threshold current between on-hook and off-hook.
$Z_{\rm M} = \frac{V_{\rm MG}}{V_{\rm M2W}} \bullet \frac{K_1(\omega)Z_{\rm L} \bullet Z_{\rm T}}{Z_{\rm T} + 0.51 \bullet K_1(\omega)(2R_{\rm F} + Z_{\rm L})}$	$\begin{split} & Z_{M} \text{ is connected from } V_{MG} \text{ (metering source) to the RSN pin,} \\ & V_{M2W} \text{ is the desired magnitude of the metering signal at the } \\ & 2\text{-wire output (usually 2.2 Vrms) and } K_1(\omega) \text{ is defined below.} \\ & K_1(\omega) = \frac{1000}{1 + j\omega(11.5 \bullet 10^{-9} + CX/2)(36 + Z_L + 2R_F)} \\ & \text{where: } CX = The values of the identical capacitors \\ & \text{ from A and B to GND} \\ & \omega = 2\pi \bullet metering frequency \end{split}$

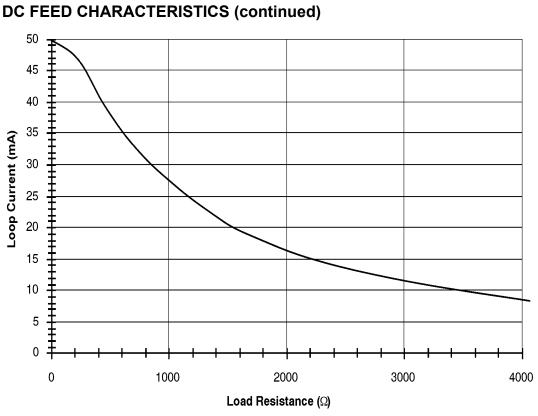
 Table 2.
 User-Programmable Components

#### DC FEED CHARACTERISTICS



a. V<sub>A</sub>–V<sub>B</sub> (V<sub>AB</sub>) Voltage vs. Loop Current (Typical)

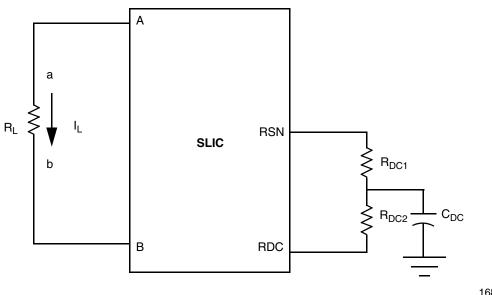
Legerity.



 $V_{BAT} = 47.3 V$  $R_{DC} = 40 k\Omega$ 

egerity.

b. Loop Current vs. Load Resistance (Typical)



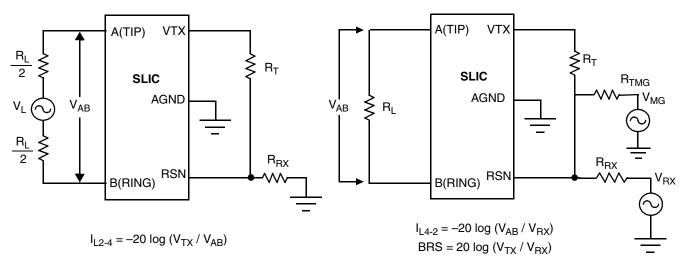
Feed resistance programmed by  $\mathsf{R}_{\mathsf{DC1}}$  and  $\mathsf{R}_{\mathsf{DC2}}$ 

16857C-004

#### c. Feed Programming

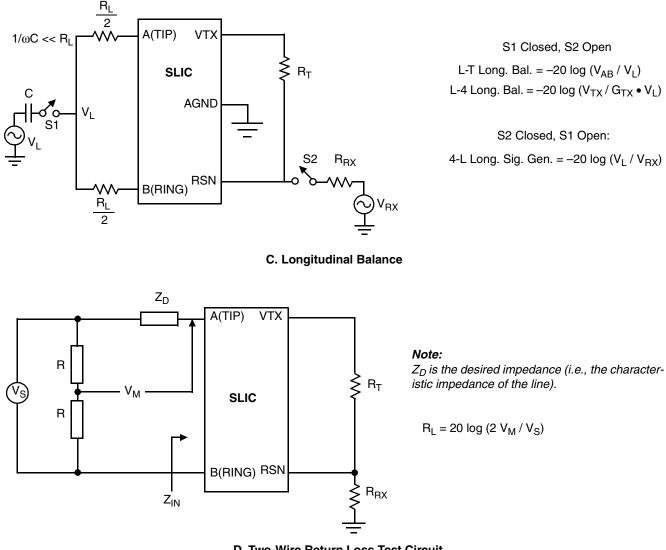
Figure 1. DC Feed Characteristics

#### **TEST CIRCUITS**



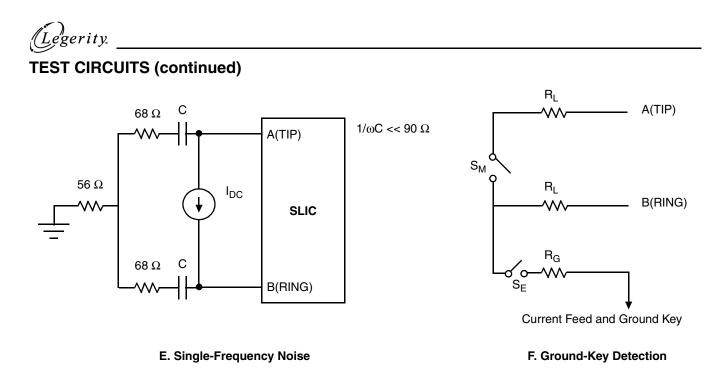


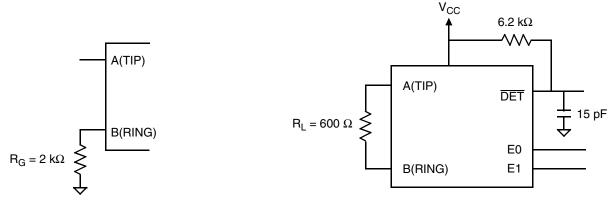
B. Four- to Two-Wire Insertion Loss and Balance Return Signal



D. Two-Wire Return Loss Test Circuit

egerity.

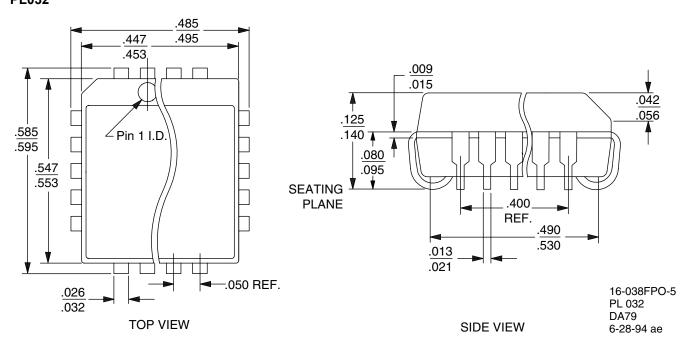




G. Ground-Key Switching

H. Loop-Detector Switching

#### PHYSICAL DIMENSION PL032



#### **REVISION SUMMARY**

#### **Revision B to Revision C**

- Minor changes were made to the data sheet style and format to conform to Legerity standards.
- In the Pin Description table, inserted/changed TP pin description to: "Thermal pin. Connection for heat dissipation. Internally connected to substrate (QBAT). Leave as open circuit or connected to QBAT. In both cases, the TP pins can connect to an area of copper on the board to enhance heat dissipation."

#### **Revision C to Revision D**

• Minor changes were made to the data sheet style and format to conform to Legerity standards.

#### **Revision D to Revision E**

- The physical dimension (PL032) was added to the Physical Dimension section.
- Deleted the Ceramic DIP and Plastic DIP part (Am79570) and references to it.
- Updated the Pin Description table to correct inconsistencies.

, Legerity Legerity provides silicon solutions that enhance the performance, speeds time-to-market, and lowers the system cost of our customers' products. By combining process, design, systems architecture, and a complete set of software and hardware support tools with unparalleled factory and worldwide field applications support, Legerity ensures its customers enjoy a smoother design experience. It is this commitment to our customers that places Legerity in a class by itself.

The contents of this document are provided in connection with Legerity, Inc. products. Legerity makes no representations or warranties with respect to the accuracy or completeness of the contents of this publication and reserves the right to make changes to specifications and product descriptions at any time without notice. No license, whether express, implied, arising by estoppel or otherwise, to any intellectual property rights is granted by this publication. Except as set forth in Legerity's Standard Terms and Conditions of Sale, Legerity assumes no liability whatsoever, and disclaims any express or implied warranty, relating to its products including, but not limited to, the implied warranty of merchantability, fitness for a particular purpose, or infringement of any intellectual property right.

Legerity's products are not designed, intended, authorized or warranted for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of Legerity's product could create a situation where personal injury, death, or severe property or environmental damage may occur. Legerity reserves the right to discontinue or make changes to its products at any time without notice.

© 1999 Legerity, Inc. All rights reserved.

#### Trademarks

Legerity, the Legerity logo and combinations thereof, DSLAC and QSLAC are trademarks of Legerity, Inc.

Other product names used in this publication are for identification purposes only and may be trademarks of their respective companies.

(Legerity.

P.O. Box 18200 Austin, Texas 78760-8200

Telephone: (512) 228-5400 Fax: (512) 228-5510 North America Toll Free: (800) 432-4009

To contact the Legerity Sales Office nearest you, or to download or order product literature, visit our website at **www.legerity.com.** 

To order literature in North America, call: (800) 572-4859 or email: americalit@legerity.com

To order literature in Europe or Asia, call: 44-0-1179-341607 or email: Europe — eurolit@legerity.com Asia — asialit@legerity.com